

ATTENTION OBSERVE PRECAUTIONS FOR HANDLING ELECTROSTATIC DISCHARGE SENSITIVE DEVICES

#### Features

- Industry standard PLCC-2 package.
- High reliability LED package.
- Wide viewing angle.
- Single color.
- Suitable for all SMT assembly and solder process.
- Available on tape and reel.
- Ideal for backlighting.
- Package : 1500pcs / reel.
- Moisture sensitivity level : level 3.
- RoHS compliant.

#### Package Dimensions

#### 3.5x2.8mm SURFACE MOUNT LED LAMP

Part Number: AA3528VRBX1S-TR-AMT Blue

#### Description

The source color devices are made with InGaN Light Emitting Diode.

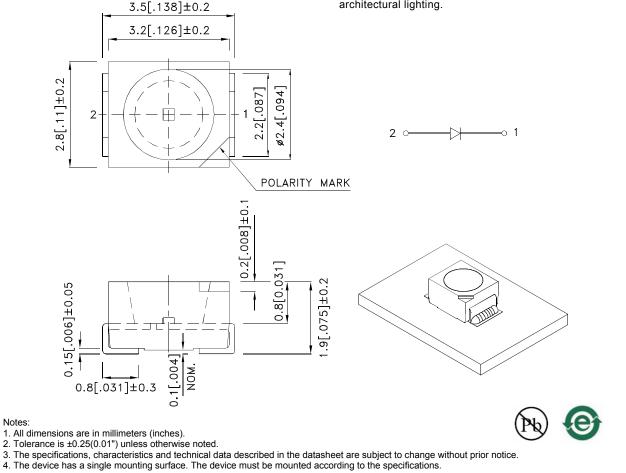
Static electricity and surge damage the LEDS.

It is recommended to use a wrist band or anti-electrostatic glove when handling the LEDs.

All devices, equipment and machinery must be electrically grounded.

#### Applications

- Traffic signaling.
- Backlighting (illuminated advertising , general lighting).
- Interior and exterior automotive lighting.
- Substitution of micro incandescent lamps.
- Reading lamps.
- Signal and symbol luminaire for orientation.
- Marker lights (e.g. Steps, exit ways, etc).
- Decorative and entertainment lighting.
- Indoor and outdoor commercial and residential architectural lighting.



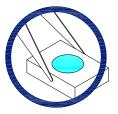
SPEC NO: DSAL4986 APPROVED: WYNEC REV NO: V.1 CHECKED: Allen Liu DATE: DEC/23/2010 DRAWN: C.H.HAN

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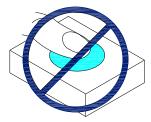
### **Handling Precautions**

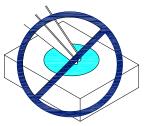
Compare to epoxy encapsulant that is hard and brittle, silicone is softer and flexible. Although its characteristic significantly reduces thermal stress, it is more susceptible to damage by external mechanical force. As a result, special handling precautions need to be observed during assembly using silicone encapsulated LED products. Failure to comply might lead to damage and premature failure of the LED.

1. Handle the component along the side surfaces by using forceps or appropriate tools.

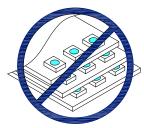


2. Do not directly touch or handle the silicone lens surface. It may damage the internal circuitry.





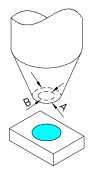
3. Do not stack together assembled PCBs containing exposed LEDs. Impact may scratch the silicone lens or damage the internal circuitry.



4.1. The outer diameter of the SMD pickup nozzle should not exceed the size of the LED to prevent air leaks. The inner diameter of the nozzle should be as large as possible.

4.2. A pliable material is suggested for the nozzle tip to avoid scratching or damaging the LED surface during pickup.

4.3. The dimensions of the component must be accurately programmed in the pick-and-place machine to insure precise pickup and avoid damage during production.



5. As silicone encapsulation is permeable to gases, some corrosive substances such as  $H_2S$  might corrode silver plating of leadframe. Special care should be taken if an LED with silicone encapsulation is to be used near such substances.

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#### Selection Guide

| Part No.            | Dice         | Lens Type   | lv (mcd) [2]<br>@ 20mA |      |      | Viewing<br>Angle [1] |
|---------------------|--------------|-------------|------------------------|------|------|----------------------|
|                     |              |             | Code.                  | Min. | Max. | 201/2                |
|                     |              |             | U                      | 1000 | 1300 |                      |
| AA3528VRBX1S-TR-AMT | Blue (InGaN) | Water Clear | V                      | 1300 | 1600 | 120°                 |
|                     |              |             | W                      | 1600 | 1900 |                      |

Notes:

θ1/2 is the angle from optical centerline where the luminous intensity is 1/2 of the optical peak value.
Luminous intensity/ luminous Flux: +/-15%.

### Absolute Maximum Ratings at Ta=25°C

| Parameter  | Symbol | Value       | Unit |
|--|--------|-------------|------|
| Power dissipation PD                             |        | 120         | mW   |
| Reverse Voltage                                  | VR     | 5           | V    |
| Junction temperature                             | TJ     | 110         | °C   |
| Operating Temperature                            | Тор    | -40 To +100 | °C   |
| Storage Temperature                              | Tstg   | -40 To +110 | °C   |
| DC Forward Current[1] IF                         |        | 30          | mA   |
| Peak Forward Current [2] IFM                     |        | 100         | mA   |
| Electrostatic Discharge Threshold (HBM)          | 250    | V           |      |
| Thermal Resistance (Junction/ambient) [1] Rth j- |        | 300         | °C/W |

Notes:

Rth(j-a) Results from mounting on PC board FR4 (pad size≥16 mm<sup>2</sup> per pad),
1/10 Duty Cycle, 0.1ms Pulse Width.

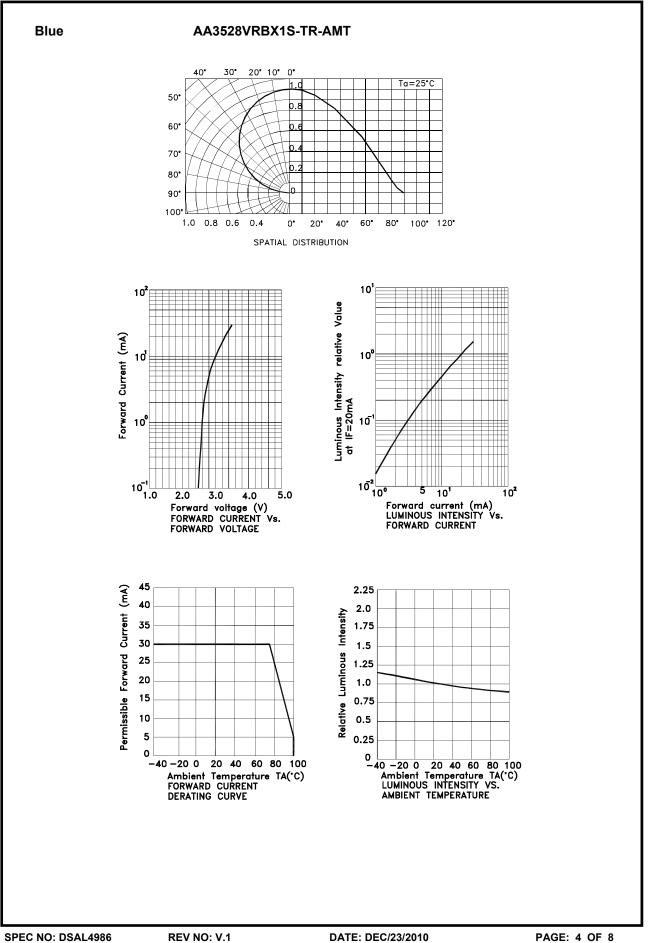
### Electrical / Optical Characteristics at Ta=25°C

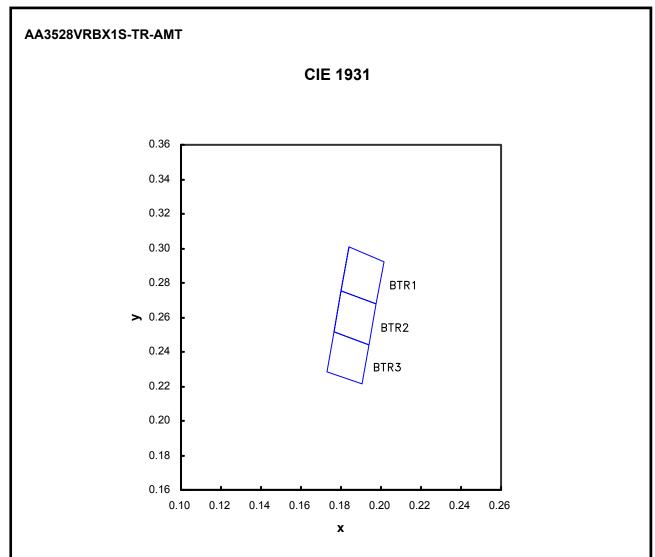
| Parameter   | Symbol | Value                    | Unit                  |
|---|--------|--------------------------|-----------------------|
|   | X [1]  | 0.19                     | -                     |
| Chromaticity Coordinates IF=20mA                                | Y[1]   | 0.26                     | -                     |
| Forward Voltage IF=20mA [Min.]                                  |        | -                        |                       |
| Forward Voltage IF=20mA [Typ.]                                  | VF [2] | 3.3                      | V                     |
| Forward Voltage IF=20mA [Max.]                                  |        | 4.0                      |                       |
| Reverse Current (VR = 5V) [Max.]                                | lr     | 50                       | uA                    |
| Temperature coefficient of VF<br>IF=20mA, -10°C≤ T≤100°C [Typ.] | TCv    | -2.2                     | mV/° C                |
| Temperature coefficient of X<br>IF=20mA, -10°C≤ T≤100°C [Typ.]  | TCx    | -0.1 10 <sup>-3</sup> /° |                       |
| Temperature coefficient of Y<br>IF=20mA, -10°C≤ T≤100°C [Typ.]  | TCy    | -0.2                     | 10 <sup>-3</sup> /° C |

Notes:

1.Measurement tolerance of the chromaticity coordinates is  $\pm 0.01$ .

2.Forward Voltage: +/-0.1V.





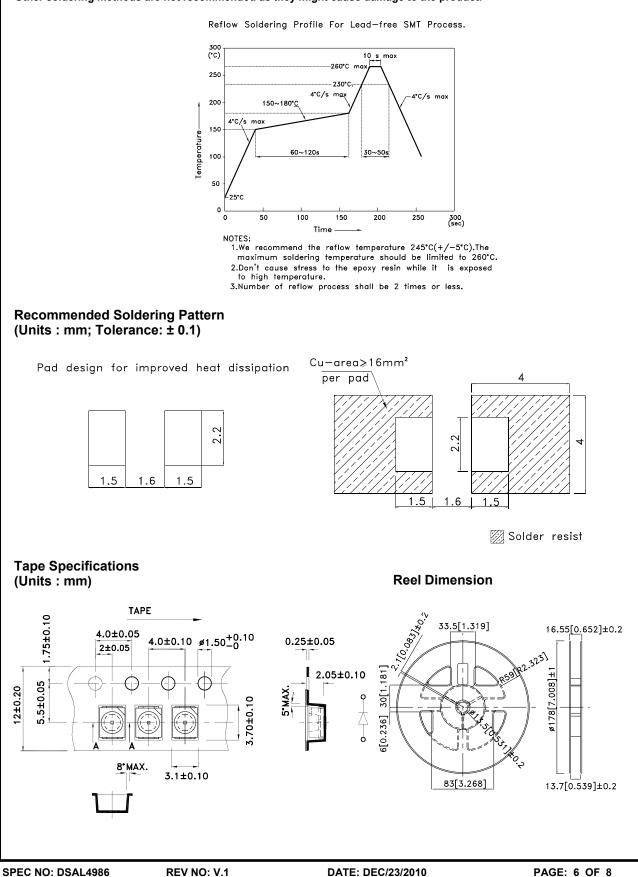
| Bin code | x      | У      | Bin code | x      | У      | Bin code | x      | У      |
|----------|--------|--------|----------|--------|--------|----------|--------|--------|
|          | 0.1840 | 0.3006 | BTR2     | 0.1801 | 0.2754 |          | 0.1764 | 0.2514 |
| BTR1     | 0.1801 | 0.2754 |          | 0.1764 | 0.2514 | BTR3     | 0.1728 | 0.2283 |
| DIRI     | 0.1976 | 0.2676 |          | 0.1939 | 0.2441 | DIRS     | 0.1903 | 0.2216 |
|          | 0.2016 | 0.2922 |          | 0.1976 | 0.2676 |          | 0.1939 | 0.2441 |

Notes:

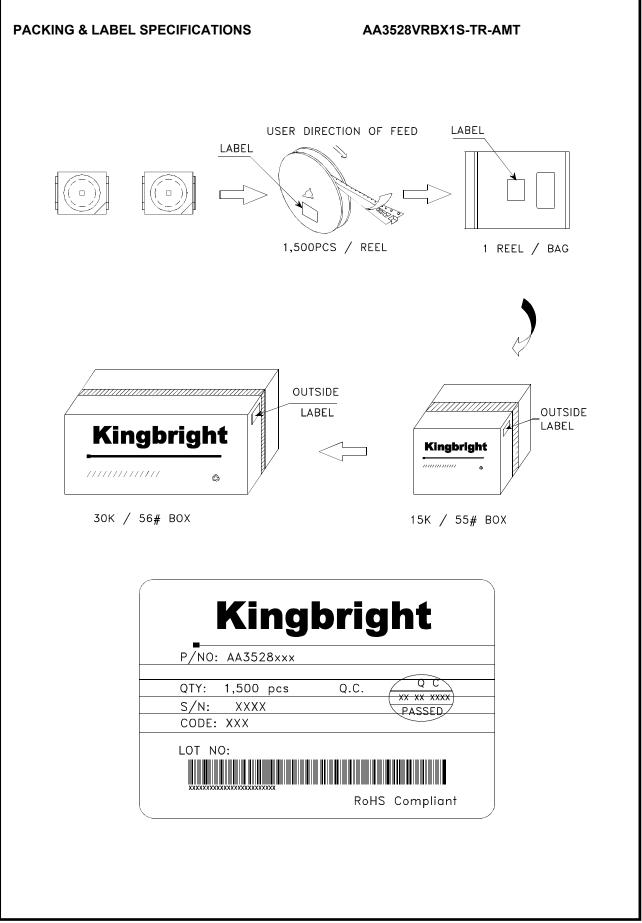
Shipment may contain more than one chromaticity regions. Orders for single chromaticity region are generally not accepted. Measurement tolerance of the chromaticity coordinates is  $\pm 0.01$ .

### AA3528VRBX1S-TR-AMT

Reflow soldering is recommended and the soldering profile is shown below. Other soldering methods are not recommended as they might cause damage to the product.



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### **Reliability Test Items And Conditions**

The reliability of products shall be satisfied with items listed below

Lot Tolerance Percent Defective (LTPD): 10%

| Test Item                            | Standards   | Test Condition   |   | Number of<br>Damaged  |
|--------------------------------------|---|--|---|---|
| Continuous operating test            | -   | Ta =25°C ,IF = maximum rated current*  | 1,000 h   | 0 / 22  |
|                                      | EIAJ ED-<br>4701/100(101)   | Ta = 100°C IF = maximum rated current*   | 1,000 h   | 0 / 22  |
| Low Temp. operating test             | -   | Ta = -40°C, IF = maximum rated current*  | 1,000 h   | 0 / 22  |
|                                      | EIAJ ED-<br>4701/100(201)   | Ta = maximum rated storage temperature   | 1,000 h   | 0 / 22  |
| l ow temp storage test               | EIAJ ED-<br>4701/100(202)   | Ta = -40°C   | 1,000 h   | 0 / 22  |
| High temp & humidity storage test    |   | Ta = 60°C, RH = 90%  | 1,000 h   | 0 / 22  |
| High temp. & humidity operating test | EIAJ ED-<br>4701/100(102)   | Ta = 60°C, RH = 90%<br>IF = maximum rated current*   | 1,000 h   | 0 / 22  |
| Soldoring reliability test           | EIAJ ED-<br>4701/100(301)   | Moisture soak : 30°C,70% RH, 72h<br>Preheat : 150~180°C(120s max.)<br>Soldering temp : 260°C(10s)  | 3 times   | 0 / 18  |
| Thermal shock operating test         | -   | Ta = -40°C(15min) ~ 100°C(15min)<br>IF = derated current at 100°C  | 1,000 cycles  | 0 / 22  |
| Thermal shock test                   | -   | Ta = -40°C(15min) ~ maximum rated<br>storage temperature(15min)  | 1,000 cycles  | 0 / 22  |
| Electric Static Discharge (ESD)      | EIAJ ED-<br>4701/100(304)   | C = 100pF , R2 = 1.5KΩ V = 250V  | Once each<br>Polarity   | 0 / 22  |
| Vibration test                       | -   | a = 196m/s² , f = 100~2KHz ,<br>t = 48min for all xyz axes   | 4 times   | 0 / 22  |
|                                      | High temp. & humidity storage test<br>High temp. & humidity operating test<br>Soldering reliability test<br>Thermal shock operating test<br>Thermal shock test<br>Electric Static Discharge (ESD) | Continuous operating test-High Temp. operating testEIAJ ED-<br>4701/100(101)Low Temp. operating test-High temp. operating test-High temp. storage testEIAJ ED-<br>4701/100(201)Low temp. storage testEIAJ ED-<br>4701/100(202)High temp. & humidity storage testEIAJ ED-<br>4701/100(103)High temp. & humidity operating testEIAJ ED-<br>4701/100(102)Soldering reliability testEIAJ ED-<br>4701/100(301)Thermal shock operating test-Electric Static Discharge (ESD)EIAJ ED-<br>4701/100(304) | Continuous operating test-Ta =25°C , IF = maximum rated current*High Temp. operating testEIAJ ED-<br>4701/100(101)Ta = 100°C IF = maximum rated current*Low Temp. operating test-Ta = -40°C, IF = maximum rated current*High temp. storage testEIAJ ED-<br>4701/100(201)Ta = maximum rated storage temperatureLow temp. storage testEIAJ ED-<br>4701/100(202)Ta = -40°CHigh temp. & humidity storage testEIAJ ED-<br>4701/100(103)Ta = 60°C, RH = 90%High temp. & humidity operating testEIAJ ED-<br>4701/100(102)Ta = 60°C, RH = 90%High temp. & humidity operating testEIAJ ED-<br>4701/100(102)Ta = 60°C, RH = 90%Soldering reliability testEIAJ ED-<br>4701/100(301)Ta = 60°C, RH = 90%Thermal shock operating testEIAJ ED-<br>4701/100(301)Moisture soak : 30°C, 70% RH, 72h<br>Preheat : 150~180°C(120s max.)<br>Soldering temp: 260°C(10s)Thermal shock test-Ta = -40°C(15min) ~ 100°C(15min)<br>IF = derated current at 100°CThermal shock test-Ta = -40°C(15min) ~ maximum rated<br>storage temperature(15min)Electric Static Discharge (ESD)EIAJ ED-<br>4701/100(304)C = 100pF , R2 = 1.5KΩ V = 250VVibration test-a = 196m/s² , f = 100~2KHz , | Test ItemStandardsTest ConditionCyclesContinuous operating test-Ta =25°C , IF = maximum rated current*1,000 hHigh Temp. operating testEIAJ ED-<br>4701/100(101)Ta = 100°C IF = maximum rated current*1,000 hLow Temp. operating test-Ta = -40°C, IF = maximum rated current*1,000 hHigh temp. storage testEIAJ ED-<br>4701/100(202)Ta = maximum rated storage temperature1,000 hLow temp. storage testEIAJ ED-<br>4701/100(202)Ta = -40°C1,000 hHigh temp. & humidity storage testEIAJ ED-<br>4701/100(103)Ta = 60°C, RH = 90%1,000 hHigh temp. & humidity operating testEIAJ ED-<br>4701/100(102)Ta = 60°C, RH = 90%1,000 hHigh temp. & humidity operating testEIAJ ED-<br>4701/100(102)Ta = 60°C, RH = 90%1,000 hSoldering reliability testEIAJ ED-<br>4701/100(301)Moisture soak : 30°C,70% RH, 72h<br>Preheat : 150-180°C(120 max.)<br>Soldering temp : 260°C(10s)3 timesThermal shock operating test-Ta = -40°C(15min) ~ 100°C(15min)<br>IF = derated current at 100°C1,000 cyclesThermal shock test-Ta = -40°C(15min) ~ maximum rated<br>storage temperature(15min)1,000 cyclesElectric Static Discharge (ESD)EIAJ ED-<br>4701/100(304)C = 100pF , R2 = 1.5KΩ V = 250VOnce each<br>PolarityVibration test-a = 196m/s² , f = 100~2KHZ ,<br>A times |

\* : Refer to forward current vs. derating curve diagram

#### **Failure Criteria**

| Items                   | Symbols | Conditions                         | Failure Criteria  |
|-------------------------|---------|------------------------------------|---|
| luminous Intensity      | lv      | IF = 20mA                          | Testing Min. Value <spec.min.value 0.5<="" td="" x=""></spec.min.value> |
| Forward Voltage         | VF      | IF = 20mA                          | Testing Max. Value ≥Spec.Max.Value x 1.2                                |
| Reverse Current         | lr      | VR = Maximum Rated Reverse Voltage | Testing Max. Value ≥Spec.Max.Value x 2.5                                |
| High temp. storage test | -       | -                                  | Occurrence of notable decoloration, deformation and cracking            |

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